## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10750072	HSIUNG ET AL.
Examiner	Art Unit
EDNA WONG	1795

SEARCHED			
Class	Subclass	Date	Examiner
205	118	6/27/07	EW
205	157	6/27/07	EW
205	159	6/27/07	EW
205	162	6/27/07	EW
205	164	6/27/07	EW
205	188	6/27/07	EW
205	205	6/27/07	EW
205	317	6/27/07	EW

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor Search	6/27/07	EW
EAST	6/27/07	EW
Search Updated	2/9/08	EW
Search Updated	8/17/08	EW

	INTERFERENCE SEA	RCH	
Class	Subclass	Date	Examiner

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